

Search Notes**Application/Control No.**

10/520,169

Examiner

Shin-Lin Chen

Applicant(s)/Patent under Reexamination

BACON ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
424	184.1	5/28/2009	SLC
435	320.1		
	455	5/28/2009	SLC
530	350	5/28/2009	SLC
536	23.5	5/28/2009	SLC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated, inventor name search.	5/28/2009	SLC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
424	184.1	5/28/2009	SLC
435	320.1		
	455	5/28/2009	SLC
530/350, 536/23.5, AU interference search		5/28/2009	SLC